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RF EXPOSURE Test Report

Report No.: MTi240430007-01E3

Date of issue: 2024-05-29

Applicant: Zhuhai Quin Technology Co., Ltd.

Product: Multifunctional Portable Label Maker

Model(s): M220, M220 Pro, M333, M333 Pro, M324, M324 Pro, M325, M325 Pro, M200, M200 Pro, M330, M330 Pro, M208, M208 Pro, M331, M331 Pro, M209, M209 Pro, M332, M332 Pro, M221, M221 Pro, M334, M334 Pro, M321, M321 Pro, M335, M335 Pro, M322, M322 Pro, M336, M336 Pro, M326, M326 Pro, M327, M327 Pro, M250, M323, M323 Pro, M337, M337 Pro, M260

FCC ID: 2ASRB-3INCH

Shenzhen Microtest Co., Ltd.

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TEST RESULT CERTIFICATION	
Applicant's name.....	Zhuhai Quin Technology Co., Ltd.
Address.....	ROOM 103-029(CENTRALIZED OFFICE AREA), 1F, BUILDING 1, NO. 18 FUTIAN ROAD, XIANGZHOU DISTRICT, ZHUHAI CITY, CHINA
Manufacturer's Name	Zhuhai Quin Technology Co., Ltd.
Address.....	ROOM 103-029(CENTRALIZED OFFICE AREA), 1F, BUILDING 1, NO. 18 FUTIAN ROAD, XIANGZHOU DISTRICT, ZHUHAI CITY, CHINA
Product description	
Product name.....	Multifunctional Portable Label Maker
Trademark	N/A
Model Name	M220
Serial Model.....	M220 Pro, M333, M333 Pro, M324, M324 Pro, M325, M325 Pro, M200, M200 Pro, M330, M330 Pro, M208, M208 Pro, M331, M331 Pro, M209, M209 Pro, M332, M332 Pro, M221, M221 Pro, M334, M334 Pro, M321, M321 Pro, M335, M335 Pro, M322, M322 Pro, M336, M336 Pro, M326, M326 Pro, M327, M327 Pro, M250, M323, M323 Pro, M337, M337 Pro, M260
Standards.....	N/A
Test procedure.....	KDB 447498 D01 v06
Date of Test	
Date (s) of performance of tests..... :	2024-05-23 to 2024-05-27
Test Result..... :	Pass

Testing Engineer

:

Letter Lan.

(Letter Lan)

Technical Manager

:

David. Lee

(David Lee)

Authorized Signatory

:

Leon Chen

(Leon Chen)

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1. Standalone SAR test exclusion considerations

Unless specifically required by the published RF exposure KDB procedures, standalone 1-g head or body and 10-g extremity SAR evaluation for general population exposure conditions, by measurement or numerical simulation, is not required when the corresponding SAR Test Exclusion Threshold condition(s), listed below, is (are) satisfied.

These test exclusion conditions are based on source-based time-averaged maximum conducted output power of the RF channel requiring evaluation, adjusted for tune-up tolerance, and the minimum test separation distance required for the exposure conditions.

The minimum test separation distance defined in 4.1 f) is determined by the smallest distance from the antenna and radiating structures or outer surface of the device, according to the host form factor, exposure conditions and platform requirements, to any part of the body or extremity of a user or bystander.

To qualify for SAR test exclusion, the test separation distances applied must be fully explained and justified, typically in the SAR measurement or SAR analysis report, by the operating configurations and exposure conditions of the transmitter and applicable host platform requirements, according to the required published RF exposure KDB procedures.

When no other RF exposure testing or reporting are required, a statement of justification and compliance must be included in the equipment approval, in lieu of the SAR report, to qualify for SAR test exclusion.

When required, the device specific conditions described in the other published RF exposure KDB procedures must be satisfied before applying these SAR test exclusion provisions.

- a) For 100 MHz to 6 GHz and test separation distances ≤ 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following:

$$[(\text{max. power of channel, including tune-up tolerance, mW}) / (\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0 \text{ for 1-g SAR, and } \leq 7.5 \text{ for 10-g extremity SAR, where}$$

- $f_{(\text{GHz})}$ is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- The values 3.0 and 7.5 are referred to as *numeric thresholds* in step b) below

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm, and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm according to 4.1 f) is applied to determine SAR test exclusion.

- b) For 100 MHz to 6 GHz and test separation distances > 50 mm, the 1-g and 10-g SAR test exclusion thresholds are determined by the following (also illustrated in Appendix B):

- 1) $\{[\text{Power allowed at } \textit{numeric threshold} \text{ for } 50 \text{ mm in step a)}] + [(\text{test separation distance} - 50 \text{ mm}) \cdot (f(\text{MHz})/150)]\}$ mW, for 100 MHz to 1500 MHz
- 2) $\{[\text{Power allowed at } \textit{numeric threshold} \text{ for } 50 \text{ mm in step a)}] + [(\text{test separation distance} - 50 \text{ mm}) \cdot 10]\}$ mW, for > 1500 MHz and ≤ 6 GHz

- c) For frequencies below 100 MHz, the following may be considered for SAR test exclusion (also illustrated in Appendix C):

- 1) For test separation distances > 50 mm and < 200 mm, the power threshold at the corresponding test separation distance at 100 MHz in step b) is multiplied by $[1 + \log(100/f(\text{MHz}))]$

- 2) For test separation distances ≤ 50 mm, the power threshold determined by the equation in c) 1) for 50 mm and 100 MHz is multiplied by $\frac{1}{2}$
- 3) SAR measurement procedures are not established below 100 MHz.

When SAR test exclusion cannot be applied, a KDB inquiry is required to determine SAR evaluation requirements for any SAR test results below 100 MHz to be acceptable.

2. SAR Test Exclusion Thresholds

We use 5mm as separation distance to calculated.

Bluetooth DSS:

Transmit Frequency (GHz)	Mode	Measured Power (dBm)	Tune-up power (dBm)	Max tune-up	Result	1g SAR test exclusion threshold
				power(dBm)	calculation	
2.402	GFSK	4.76	4 $\pm$ 1	5	0.9802	3
2.441		3.53	3 $\pm$ 1	4	0.7849	3
2.480		4.95	4 $\pm$ 1	5	0.9960	3
2.402	$\pi/4$ DQPSK	4.42	4 $\pm$ 1	5	0.9802	3
2.441		4.43	4 $\pm$ 1	5	0.9881	3
2.480		5.67	5 $\pm$ 1	6	1.2539	3

Bluetooth DTS:

Transmit Frequency (GHz)	Mode	Measured Power (dBm)	Tune-up power (dBm)	Max tune-up	Result	1g SAR test exclusion threshold
				power(dBm)	calculation	
2.402	GFSK-1M	4.48	4 $\pm$ 1	5	0.9802	3
2.440		4.80	4 $\pm$ 1	5	0.9879	3
2.480		5.14	5 $\pm$ 1	6	1.2539	3
2.402	GFSK-2M	4.47	4 $\pm$ 1	5	0.9802	3
2.440		4.87	4 $\pm$ 1	5	0.9879	3
2.480		5.22	5 $\pm$ 1	6	1.2539	3

Conclusion:

For the max result: $1.2539 \leq 3.0$, No SAR is required.

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